

# Lecture 6:Testing Sparse images

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# Models of testing graph properties

## Dense graph model

- Adjacency predicate:  $g : \binom{V}{2} \rightarrow \{0, 1\}$ -  $g(\{u, v\}) = [\{u, v\} \in E]$  (truth value)
- Alternatively:  $g: V \times V \rightarrow \{0, 1\}$

 $- g(u, v) = [\{u, v\} \in E]$  (truth value)

• Distance:  $\delta(G, G') = \delta(g, g') = \frac{|\{u, v\}: g(u, v) \neq g'(u, v)|}{|V|^2}$ -  $\delta_{\Pi}(G) = \min_{G' \in \Pi, \pi} \left\{ \frac{|\{u, v\}: g(u, v) \neq g'(\pi(u), \pi(v))|}{|V|^2} \right\}$ 



# Models of testing graph properties

Bounded degree graph model

- Incidence function:  $g: g: V \times [d] \rightarrow V \cup \{\bot\}$ 
  - $-g(\lbrace u,i\rbrace) = v$ , where v is the *i*-th neighbor of u.

$$- g(\{u,i\}) = \perp \text{ if } d(u) < i.$$

**Distance**: *G* is  $\epsilon$ - far from a graph property  $\Pi$  if for any permutation  $\pi$  over *V*, the following holds:

$$\sum_{u\in V} \left| \{v: \exists i \ g(u,i)=v\} \triangle \{v: \exists i \ g'(\pi(u),i)=\pi(v)\} \right| \ > \ \epsilon dN \,,$$

where N = |V|.



# Models of testing graph properties

# General graph model

- Both representations and types of queries used.
- Distance:  $\delta(G, G') = \frac{|E \Delta E'|}{\max\{|E|, |E'|\}}$
- More general that the other models.
- Not as easy to use.

# Which model to use?

 Depends on the graphs contained in Π and the type of queries used.



# Definitions

## Images:

- An image will be represented by a 0/1-valued  $n \times n$  matrix M.
  - Dense if it contains  $\Omega(n^2)$  1-entries/pixels.

# Access models:

- Dense image model: (analog to dense graph model)
  - Query access to entries
- Sparse image model: (analog to sparse graph model)
  - Query access to entries
  - Sample access to 1-entries

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#### Distance:

- Dense image model:  $\delta(M, M') = \frac{d_H(M, M')}{n^2}$
- Sparse image model:  $\delta(M, M') = \frac{d_H(M, M')}{w(M)}$ where w(M) is the number of 1-pixels in M

# Example properties

- Connectivity: Graph of *M* is connected
- Line imprint: ∃ a line segment such that M(i, j) = 1 iff the line intersects the pixel.
- Convexity: Similar for a convex shape
- Monotonicity:  $\forall$   $(i_1, j_1)$  and  $(i_2, j_2)$  1-pixels it holds:  $i_1 < i_2 \Rightarrow j_1 \le j_2$ .





# VC dimension and $\epsilon\text{-nets}$

# Definition ( $\epsilon$ -nets )

Let *X* be a set,  $\mu$  a probability measure on *X*,  $\mathcal{F}$  be a system of  $\mu$ -measurable subsets of *X* and  $\epsilon > 0$ . A subset  $N \subseteq X$  is called an  $\epsilon$ -net for  $(X, \mathcal{F})$  with respect to  $\mu$  if  $N \cap S \neq \emptyset$  for all  $S \in \mathcal{F}$  with  $\mu(S) \ge \epsilon$ .

In our case ( $\epsilon$ -net on the differences of images):

- $X = \mathbb{R}^d$
- { $M_1, \ldots, M_k$ } is a set of images. -  $\mathcal{F} = \{M_i \Delta M_j\}_{i \neq j \leq k}$
- If Pr<sub>(i,j)∼μ</sub>[M<sub>1</sub>(i,j) ≠ M<sub>2</sub>(i,j)] > ε, then the ε-net N contains at least one pixel on which M<sub>1</sub>, M<sub>2</sub> differ.



# Definition (VC-dimension)

Let  $\mathcal{F}$  be a set system on X We say that  $A \subseteq X$  is shattered by  $\mathcal{F}$  if each of the subsets of A can be obtained as the intersection of some  $S \in \mathcal{F}$  with A. We call VC-dimension of a set system  $\mathcal{F}(\text{denoted by } dim(\mathcal{F}))$  the supremum of the sizes of all shattered subsets of  $\mathcal{F}$ .

**Example 1:** Halfspaces in  $\mathbb{R}^2$ : VC dimension = 3



**Example 2:** Convex sets in  $\mathbb{R}^2$ : VC dimension =  $\infty$ 



#### Theorem ( $\epsilon$ -net theorem)

Let C be a class of images with VC dimension d. There exists a constant  $c_1$  such that for any distribution D the following holds: If N consists of  $c_1 \frac{d \log(1/\epsilon)}{\epsilon}$  pixels drawn according to D, then it is an  $\epsilon$ -net for C with high constant probability.

#### Corollary

Let w = w(M) denote the number of 1-pixels of an image M. Then, there exists a property tester for membership in C, that given w(M) has sample complexity  $O(d \log(1/\epsilon)/\epsilon)$ .

#### Proof:



# **Testing Line imprints**

# Definition

# The imprint of a line segment in $\mathbb{R}^2$ is the set of pixels it intersects.



# Definition

The sleeve defined by 2 pixels  $p_1$ ,  $p_2$  is the union of all line imprints of line segments that start in  $p_1$  and end in  $p_2$ .



# Property tester

- 1. Take a sample  $S_1$  of size  $m_1 = \Theta(1/\epsilon)$  uniformly from the 1-pixels of M and find 2 pixels  $p_1, p_2$  with maximum distance between them.
- 2. Take another sample  $S_2$  of size  $m_2 = \Theta(1/\epsilon)$  1-pixels of M we distinguish this from  $S_1$  for analysis purposes.
- 3. Let *P* be the sleeve of  $p_1, p_2$ . Query *M* on a set *Q* of size  $m_3 = \Theta(\frac{\log(1/\epsilon)}{\epsilon})$  pixels of *P*. If there exists a line imprint that is consistent with the 1-pixels is  $S_1 \cup S_2$  and the queries in *Q*, then ACCEPT. Otherwise REJECT.



#### Theorem

The above property tester is an one-sided error tester for the property of being a line imprint. with sample and query complexity of  $O(\frac{\log(1/\epsilon)}{\epsilon})$  and running time of  $O(1/\epsilon)$ .

Proof:

